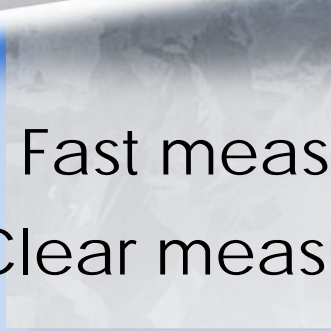
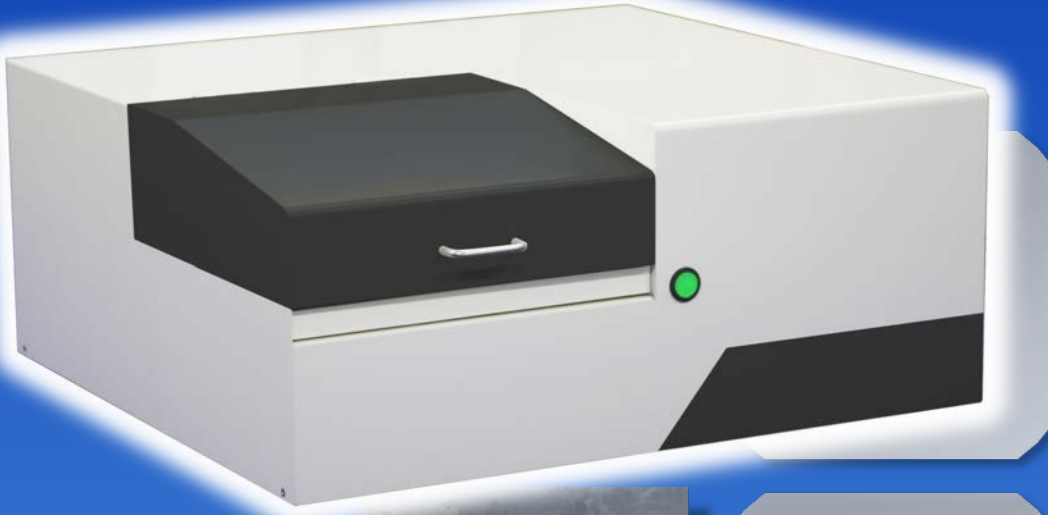




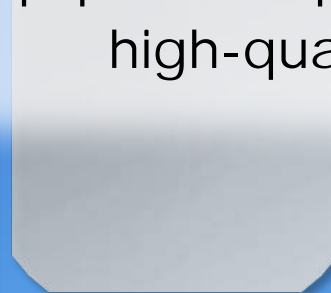
Effective Carrier Measurement Device
for Silicon Wafer of Solar Cell

VWECER-100-S



Fast measurement time
Clear measurement results

Our equipment supports the production of
high-quality solar cells.



Device Specification		Measurement Performance	
Size	W:600xH:250xD:550 mm	Measuring time	About 30 sec / wafer
Weight	50 kg	Measuring Method	Probe contact type
Power	Single-phase AC100 - 240V	Measuring Range	156x156x0.2±0.05 mm (Can be changed by option)
Operating Environment	Temperature and Humidity 25±5°C · ≤85%RH	Measuring Object	p/n type Monocrystal · Polycrystal